## Statistical Data Analysis 2020/21 Lecture Week 9



London Postgraduate Lectures on Particle Physics University of London MSc/MSci course PH4515



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www.pp.rhul.ac.uk/~cowan/stat\_course.html

# Statistical Data Analysis Lecture 9-1

Least squares with histogram data

#### LS with histogram data

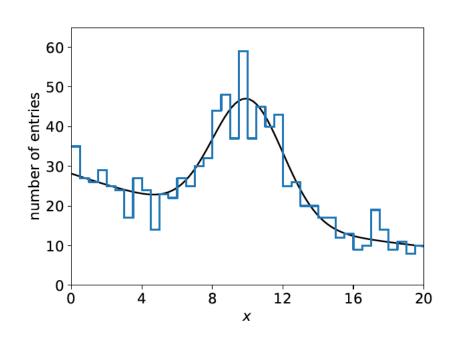
The fit function in an LS fit is not a pdf, but it could be proportional to one, e.g., when we fit the "envelope" of a histogram.

Suppose for example, we have an i.i.d. data sample of n values  $x_1,...,x_n$  sampled from a pdf  $f(x;\theta)$ . Goal is to estimate  $\theta$ .

Instead of using all n values, put them in a histogram with N bins, i.e.,  $y_i$  = number of entries in bin i:  $\mathbf{y} = (y_1, ..., y_N)$ .

The model predicts mean values:

$$E[y_i] = \mu_i(m{ heta})$$
 
$$= n \int_{\mathrm{bin}\,i} f(x;m{ heta})\,dx$$
 
$$pprox nf(x_i;m{ heta})\,\Delta x$$
 bin centre bin widtl



## LS with histogram data (2)

#### The usual models:

for fixed sample size n, take  $y \sim$  multinomial, if n not fixed,  $y_i \sim$  Poisson( $\mu_i$ )

Suppose that the expected number of entries in each  $\mu_i$  are all  $\gg 1$  and probability to be in any individual bin  $p_i \ll 1$ , one can show

 $\rightarrow y_i$  indep. and  $\sim$  Gauss with  $\sigma_i \approx \sqrt{\mu_i}$ . ( $\rightarrow \sigma_i$  depends on  $\theta$ ).

The (log-) likelihood functions are then

$$L(\boldsymbol{\theta}) = \prod_{i=1}^{N} \frac{1}{\sqrt{2\pi}\sigma_i(\boldsymbol{\theta})} e^{-(y_i - \mu_i(\boldsymbol{\theta}))^2/2\sigma_i^2(\boldsymbol{\theta})}$$

$$\ln L(\boldsymbol{\theta}) = -\frac{1}{2} \sum_{i=1}^{N} \frac{(y_i - \mu_i(\boldsymbol{\theta}))^2}{\sigma_i(\boldsymbol{\theta})^2} - \sum_{i=1}^{N} \ln \sigma_i(\boldsymbol{\theta}) + C$$

#### LS with histogram data (3)

Still define the least-squares estimators to minimize

$$\chi^{2}(\boldsymbol{\theta}) = \sum_{i=1}^{N} \frac{(y_{i} - \mu_{i}(\boldsymbol{\theta}))^{2}}{\sigma_{i}(\boldsymbol{\theta})^{2}}$$

No longer equivalent to maximum likelihood (equal for  $\mu_i \gg 1$  ).

Two possibilities for  $\sigma_i$ :

$$\sigma_i = \sqrt{\mu_i(\boldsymbol{\theta})}$$
 (LS method) 
$$\sigma_i = \sqrt{y_i}$$
 (Modified LS method)

Modified LS can be easier computationally but not defined if any  $y_i = 0$ .

For either method,  $\chi^2_{\min} \sim \text{chi-square pdf for } \mu_i \gg 1$ , but this breaks down for when the  $\mu_i$  are not large.

#### LS with histogram data — normalization

Do not "fit" the normalization, i.e.,  $n \rightarrow$  free parameter v:

$$\mu_i(\boldsymbol{\theta}, \nu) = \nu \int_{\text{bin } i} f(x; \boldsymbol{\theta}) dx$$

If you do this, one finds the LS estimator for v is not n, but rather

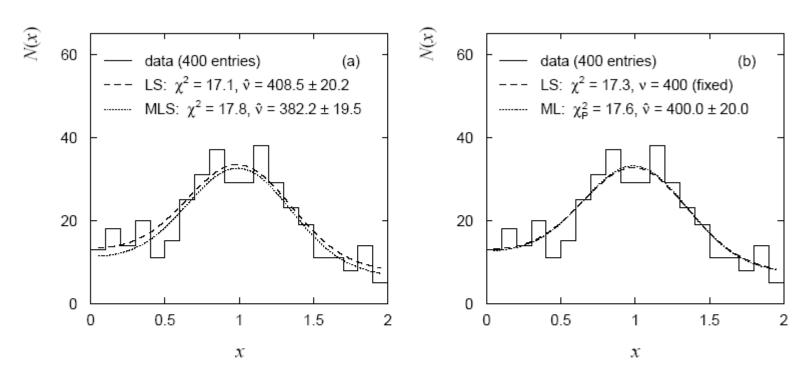
$$\hat{\nu}_{\rm LS} = n + \frac{\chi_{\rm min}^2}{2}$$

$$\hat{\nu}_{\text{MLS}} = n - \chi_{\text{min}}^2$$

Software may include adjustable normalization parameter as default; better to use known n.

#### LS normalization example

Example with n = 400 entries, N = 20 bins:



Expect  $\chi^2_{\min}$  around N-m,

 $\rightarrow$  relative error in  $\hat{\nu}$  large when N large, n small

Either get n directly from data for LS (or better, use ML).

# Statistical Data Analysis Lecture 9-2

- Goodness-of-fit from the likelihood ratio
- Wilks' theorem
- MLE and goodness-of-fit all in one

#### Goodness of fit from the likelihood ratio

Suppose we model data using a likelihood  $L(\mu)$  that depends on N parameters  $\mu = (\mu_1, ..., \mu_N)$ . Define the statistic

$$t_{\mu} = -2\ln\frac{L(\mu)}{L(\hat{\mu})}$$

where  $\hat{\mu}$  is the ML estimator for  $\mu$ . Value of  $t_{\mu}$  reflects agreement between hypothesized  $\mu$  and the data.

Good agreement means  $\mu \approx \hat{\mu}$ , so  $t_{\mu}$  is small;

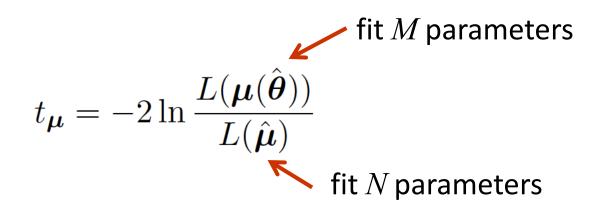
Larger  $t_u$  means less compatibility between data and  $\mu$ .

Quantify "goodness of fit" with 
$$p$$
-value:  $p_{\mu}=\int_{t_{\mu,{
m obs}}}^{\infty}f(t_{\mu}|\mu)\,dt_{\mu}$  need this pdf

#### Likelihood ratio (2)

Now suppose the parameters  $\mu = (\mu_1, ..., \mu_N)$  can be determined by another set of parameters  $\theta = (\theta_1, ..., \theta_M)$ , with M < N.

Want to test hypothesis that the true model is somewhere in the subspace  $\mu = \mu(\theta)$  versus the alternative of the full parameter space  $\mu$ . Generalize the LR test statistic to be



To get p-value, need pdf  $f(t_{\mu}|\mu(\theta))$ .

#### Wilks' Theorem

Wilks' Theorem: if the hypothesized  $\mu_i(\theta)$ , i=1,...,N, are true for some choice of the parameters  $\theta=(\theta_1,...,\theta_M)$ , then in the large sample limit (and provided regularity conditions are satisfied)

$$t_{\pmb{\mu}} = -2\ln\frac{L(\pmb{\mu}(\hat{\pmb{\theta}}))}{L(\hat{\pmb{\mu}})} \qquad \text{follows a chi-square distribution for} \\ N-M \text{ degrees of freedom.} \\ \text{MLE of } (\mu_1,...,\mu_N)$$

The regularity conditions include: the model in the numerator of the likelihood ratio is "nested" within the one in the denominator, i.e.,  $\mu(\theta)$  is a special case of  $\mu = (\mu_1, ..., \mu_N)$ .

Proof boils down to having all estimators ~ Gaussian.

S.S. Wilks, The large-sample distribution of the likelihood ratio for testing composite hypotheses, Ann. Math. Statist. 9 (1938) 60-2.

#### Goodness of fit with Gaussian data

Suppose the data are N independent Gaussian distributed values:

$$y_i \sim \mathrm{Gauss}(\mu_i, \sigma_i) \;, \qquad i = 1, \dots, N$$
 want to estimate known

N measurements and N parameters ( = "saturated model")

Likelihood: 
$$L(\mu) = \prod_{i=1}^{N} \frac{1}{\sqrt{2\pi}\sigma_i} e^{-(y_i - \mu_i)^2/2\sigma_i^2}$$

Log-likelihood: 
$$\ln L(\boldsymbol{\mu}) = -\frac{1}{2} \sum_{i=1}^N \frac{(y_i - \mu_i)^2}{\sigma_i^2} + C$$

ML estimators: 
$$\hat{\mu}_i = y_i$$
  $i=1,\ldots,N$ 

#### Likelihood ratio for Gaussian data

Now suppose  $\mu = \mu(\theta)$ , e.g., in an LS fit with  $\mu_i(\theta) = \mu(x_i; \theta)$ .

The goodness-of-fit statistic for the test of the hypothesis  $\mu(\theta)$  becomes

$$t_{\boldsymbol{\mu}} = -2\ln\frac{L(\boldsymbol{\mu}(\hat{\boldsymbol{\theta}}))}{L(\hat{\boldsymbol{\mu}})} = \sum_{i=1}^{N} \frac{(y_i - \mu_i(\hat{\boldsymbol{\theta}}))^2}{\sigma_i^2} \sim \chi_{N-M}^2$$

chi-square pdf for N-M degrees of freedom

Here  $t_{\mu}$  is the same as  $\chi^2_{\min}$  from an LS fit.

So Wilks' theorem formally states the property that we claimed for the minimized chi-squared from an LS fit with N measurements and M fitted parameters.

#### Likelihood ratio for Poisson data

Suppose the data are a set of values  $n = (n_1, ..., n_N)$ , e.g., the numbers of events in a histogram with N bins.

Assume  $n_i \sim \text{Poisson}(v_i)$ , i = 1,..., N, all independent.

First (for LR denominator) treat  $v = (v_1, ..., v_N)$  as all adjustable:

Likelihood: 
$$L(oldsymbol{
u}) = \prod_{i=1}^N rac{
u_i^{n_i}}{n_i!} e^{-
u_i}$$

Log-likelihood: 
$$\ln L(oldsymbol{
u}) = \sum_{i=1}^N \left[ n_i \ln 
u_i - 
u_i \right] + C$$

ML estimators: 
$$\hat{\nu}_i = n_i$$
 ,  $i = 1, \ldots, N$ 

#### Goodness of fit with Poisson data (2)

For LR numerator find  $v(\theta)$  with M fitted parameters  $\theta = (\theta_1, ..., \theta_M)$ :

$$t_{\nu} = -2\ln\frac{L(\nu(\hat{\boldsymbol{\theta}}))}{L(\hat{\boldsymbol{\nu}})} = -2\sum_{i=1}^{N} \left[ n_i \ln\frac{\nu_i(\hat{\boldsymbol{\theta}})}{n_i} - \nu_i(\hat{\boldsymbol{\theta}}) + n_i \right]$$

Wilks' theorem: in large-sample limit  $t_{m 
u} \sim \chi^2_{N-M}$ 

Exact in large sample limit; in practice good approximation for surprisingly small  $n_i$  (~several).

As before use  $t_v$  to get p-value of  $v(\theta)$ ,

independent of 
$$m{ heta}$$
 
$$p_{m{
u}}=\int_{t_{m{
u}},{\rm obs}}^{\infty}f(t_{m{
u}}|m{
u}(m{ heta}))\,dt_{m{
u}}=1-F_{\chi^2}(t_{m{
u},{\rm obs}};N-M)$$

#### Goodness of fit with multinomial data

Similar if data  $\mathbf{n} = (n_1, ..., n_N)$  follow multinomial distribution:

$$P(\mathbf{n}|\mathbf{p}, n_{\text{tot}}) = \frac{n_{\text{tot}}!}{n_1! n_2! \dots n_N!} p_1^{n_1} p_2^{n_2} \dots p_N^{n_N}$$

E.g. histogram with N bins but fix:  $n_{tot} = \sum_{i=1}^{N} n_i$ 

Log-likelihood: 
$$\ln L(\nu) = \sum_{i=1}^N n_i \ln \frac{\nu_i}{n_{\mathrm{tot}}} + C$$
  $(\nu_i = p_i n_{\mathrm{tot}})$ 

ML estimators:  $\hat{\nu}_i = n_i$  (Only N-1 independent; one is  $n_{\rm tot}$  minus sum of rest.)

#### Goodness of fit with multinomial data (2)

The likelihood ratio statistics become:

$$t_{\nu} = -2\ln\frac{L(\nu(\hat{\boldsymbol{\theta}}))}{L(\hat{\boldsymbol{\nu}})} = -2\sum_{i=1}^{N} n_i \ln\frac{\nu_i(\hat{\boldsymbol{\theta}})}{n_i}$$

Wilks: in large sample limit  $t_{m 
u} \sim \chi^2_{N-M-1}$ 

One less degree of freedom than in Poisson case because effectively only N-1 parameters fitted in denominator of LR.

#### Estimators and g.o.f. all at once

Evaluate numerators with  $\theta$  (not its estimator); if any  $n_i$  = 0, omit the corresponding log terms:

$$\chi_{\mathrm{P}}^2(\boldsymbol{\theta}) = -2\sum_{i=1}^N \left[ n_i \ln \frac{\nu_i(\boldsymbol{\theta})}{n_i} - \nu_i(\boldsymbol{\theta}) + n_i \right]$$
 (Poisson)

$$\chi_{\mathrm{M}}^{2}(\theta) = -2\sum_{i=1}^{N} n_{i} \ln \frac{\nu_{i}(\theta)}{n_{i}}$$
 (Multinomial)

These are equal to the corresponding  $-2 \ln L(\theta)$  plus terms not depending on  $\theta$ , so minimizing them gives the usual ML estimators for  $\theta$ .

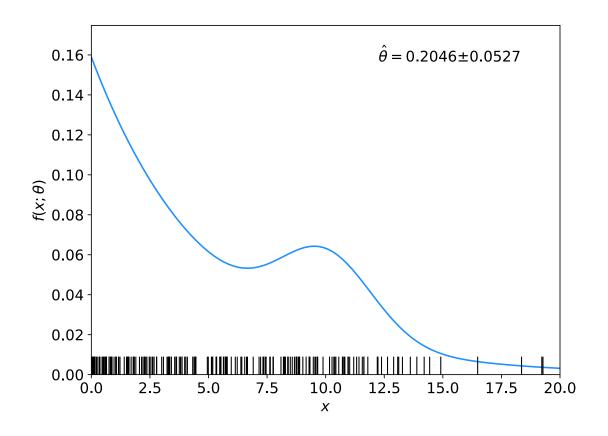
The minimized value gives the statistic  $t_v$ , so we get goodness-of-fit for free.

Steve Baker and Robert D. Cousins, Clarification of the use of the chi-square and likelihood functions in fits to histograms, NIM 221 (1984) 437.

#### Examples of ML/LS fits

Unbinned maximum likelihood (mlFit.py, minimize negLogL)

$$\ln L(\boldsymbol{\theta}) = \sum_{i=1}^{n} \ln f(x_i; \boldsymbol{\theta})$$

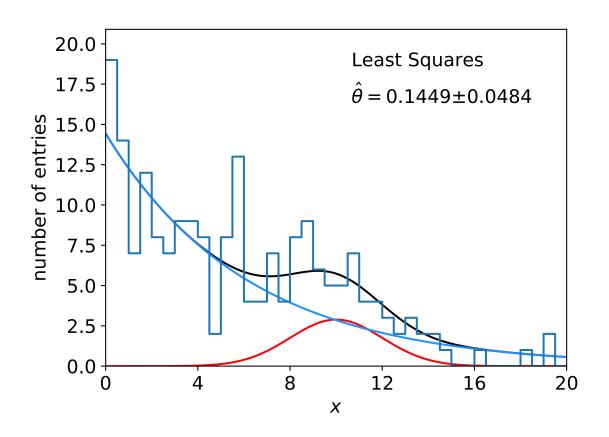


No useful measure of goodness-of-fit from unbinned ML.

## Examples of ML/LS fits

#### Least Squares fit (histFit.py, minimize chi2LS)

$$\chi^{2}(\boldsymbol{\theta}) = \sum_{i=1}^{N} \frac{(y_{i} - \mu_{i}(\boldsymbol{\theta}))^{2}}{\mu_{i}(\boldsymbol{\theta})}$$



$$\chi^2_{\min} = 32.7$$

$$n_{\text{dof}} = 38$$

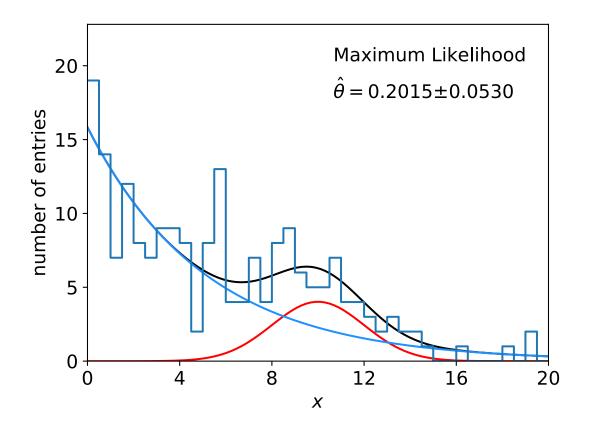
$$p = 0.71$$

Many bins with few entries, LS not expected to be reliable.

## Examples of ML/LS fits

Multinomial maximum likelihood fit (histFit.py, minimize chi2M)

$$\chi_{\mathrm{M}}^{2}(\boldsymbol{\theta}) = -2\sum_{i=1}^{N} n_{i} \ln \frac{\nu_{i}(\boldsymbol{\theta})}{n_{i}}$$



$$\chi^2_{\min} = 35.3$$

$$n_{\text{dof}} = 37$$

$$p = 0.55$$

Essentially same result as unbinned ML.

## Statistical Data Analysis Lecture 9-3

- Interval estimation
- Confidence interval from inverting a test
- Example: limits on mean of Gaussian

## Confidence intervals by inverting a test

In addition to a 'point estimate' of a parameter we should report an interval reflecting its statistical uncertainty.

Confidence intervals for a parameter  $\theta$  can be found by defining a test of the hypothesized value  $\theta$  (do this for all  $\theta$ ):

Specify values of the data that are 'disfavoured' by  $\theta$  (critical region) such that  $P(\text{data in critical region} | \theta) \leq \alpha$  for a prespecified  $\alpha$ , e.g., 0.05 or 0.1.

If data observed in the critical region, reject the value  $\theta$ .

Now invert the test to define a confidence interval as:

set of  $\theta$  values that are not rejected in a test of size  $\alpha$  (confidence level CL is  $1-\alpha$ ).

## Relation between confidence interval and p-value

Equivalently we can consider a significance test for each hypothesized value of  $\theta$ , resulting in a p-value,  $p_{\theta}$ .

If  $p_{\theta} \leq \alpha$ , then we reject  $\theta$ .

The confidence interval at  $CL = 1 - \alpha$  consists of those values of  $\theta$  that are not rejected.

E.g. an upper limit on  $\theta$  is the greatest value for which  $p_{\theta} > \alpha$ .

In practice find by setting  $p_{\theta} = \alpha$  and solve for  $\theta$ .

For a multidimensional parameter space  $\theta = (\theta_1, \dots \theta_M)$  use same idea – result is a confidence "region" with boundary determined by  $p_{\theta} = \alpha$ .

#### Coverage probability of confidence interval

If the true value of  $\theta$  is rejected, then it's not in the confidence interval. The probability for this is by construction (equality for continuous data):

$$P(\text{reject }\theta | \theta) \leq \alpha = \text{type-I error rate}$$

Therefore, the probability for the interval to contain or "cover"  $\theta$  is

$$P(\text{conf. interval "covers" }\theta | \theta) \ge 1 - \alpha$$

This assumes that the set of  $\theta$  values considered includes the true value, i.e., it assumes the composite hypothesis  $P(x|H,\theta)$ .

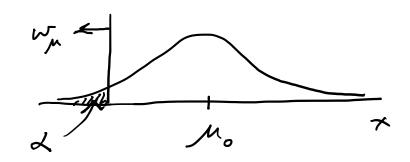
#### Example: upper limit on mean of Gaussian

When we test the parameter, we should take the critical region to maximize the power with respect to the relevant alternative(s).

Example:  $x \sim \text{Gauss}(\mu, \sigma)$  (take  $\sigma$  known)

Test  $H_0: \mu = \mu_0$  versus the alternative  $H_1: \mu < \mu_0$ 

 $\rightarrow$  Put  $w_{\mu}$  at region of x-space characteristic of low  $\mu$  (i.e. at low x)

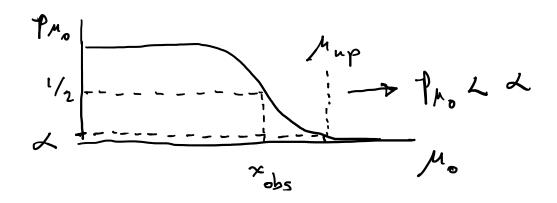


Equivalently, take the *p*-value to be

$$p_{\mu_0} = P(x \le x_{\text{obs}} | \mu_0) = \int_{-\infty}^{x_{\text{obs}}} \frac{1}{\sqrt{2\pi}\sigma} e^{-(x-\mu_0)^2/2\sigma^2} dx = \Phi\left(\frac{x_{\text{obs}} - \mu_0}{\sigma}\right)$$

## Upper limit on Gaussian mean (2)

To find confidence interval, repeat for all  $\mu_0$ , i.e., set  $p_{\mu 0} = \alpha$  and solve for  $\mu_0$  to find the interval's boundary



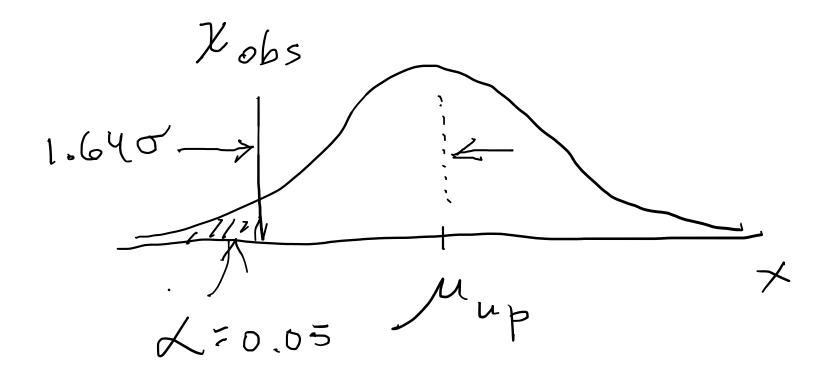
$$\mu_0 \to \mu_{\rm up} = x_{\rm obs} - \sigma \Phi^{-1}(\alpha) = x_{\rm obs} + \sigma \Phi^{-1}(1 - \alpha)$$

This is an upper limit on  $\mu$ , i.e., higher  $\mu$  have even lower p-value and are in even worse agreement with the data.

Usually use  $\Phi^{-1}(\alpha) = -\Phi^{-1}(1-\alpha)$  so as to express the upper limit as  $x_{\rm obs}$  plus a positive quantity. E.g. for  $\alpha$  = 0.05,  $\Phi^{-1}(1-0.05)$  = 1.64.

## Upper limit on Gaussian mean (3)

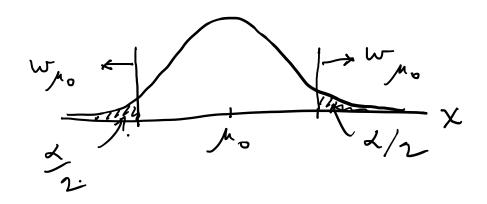
 $\mu_{\rm up}$  = the hypothetical value of  $\mu$  such that there is only a probability  $\alpha$  to find  $x < x_{\rm obs}$ .



#### 1- vs. 2-sided intervals

Now test:  $H_0: \mu = \mu_0$  versus the alternative  $H_1: \mu \neq \mu_0$ 

I.e. we consider the alternative to  $\mu_0$  to include higher and lower values, so take critical region on both sides:



Result is a "central" confidence interval [ $\mu_{lo}$ ,  $\mu_{up}$ ]:

$$\mu_{\rm lo} = x_{\rm obs} - \sigma \Phi^{-1} \left( 1 - \frac{\alpha}{2} \right)$$

$$\mu_{\rm up} = x_{\rm obs} + \sigma \Phi^{-1} \left( 1 - \frac{\alpha}{2} \right)$$

E.g. for 
$$\alpha = 0.05$$

$$\Phi^{-1}\left(1 - \frac{\alpha}{2}\right) = 1.96 \approx 2$$

Note upper edge of two-sided interval is higher (i.e. not as tight of a limit) than obtained from the one-sided test.

#### On the meaning of a confidence interval

Often we report the confidence interval [a,b] together with the point estimate as an "asymmetric error bar", e.g.,

E.g. (at CL = 
$$1 - \alpha = 68.3\%$$
):  $6 = 80.25 + 0.31$ 

Does this mean  $P(80.00 < \theta < 80.56) = 68.3\%$ ? No, not for a frequentist confidence interval. The parameter  $\theta$  does not fluctuate upon repetition of the measurement; the endpoints of the interval do, i.e., the endpoints of the interval fluctuate (they are functions of data):

P(alx) L 0 L b(x)) = 1 - x

# Statistical Data Analysis Lecture 9-4

Confidence intervals from the likelihood function

## Approximate confidence intervals/regions from the likelihood function

Suppose we test parameter value(s)  $\theta = (\theta_1, ..., \theta_n)$  using the ratio

$$\lambda(\theta) = \frac{L(\theta)}{L(\hat{\theta})} \qquad 0 \le \lambda(\theta) \le 1$$

Lower  $\lambda(\theta)$  means worse agreement between data and hypothesized  $\theta$ . Equivalently, usually define

$$t_{\theta} = -2 \ln \lambda(\theta)$$

so higher  $t_{\theta}$  means worse agreement between  $\theta$  and the data.

$$p$$
-value of  $\theta$  therefore

$$p_{m{ heta}} = \int_{t_{m{ heta}, ext{obs}}}^{\infty} f(t_{m{ heta}} | m{ heta}) \, dt_{m{ heta}}$$
 need pdf

#### Confidence region from Wilks' theorem

Wilks' theorem says (in large-sample limit and provided certain conditions hold...)

$$f(t_{\theta}|\theta) \sim \chi_n^2$$

chi-square dist. with # d.o.f. = # of components in  $\theta = (\theta_1, ..., \theta_n)$ .

Assuming this holds, the p-value is

$$p_{\theta} = 1 - F_{\chi_n^2}(t_{\theta}) \quad \leftarrow \text{set equal to } \alpha$$

To find boundary of confidence region set  $p_{\theta} = \alpha$  and solve for  $t_{\theta}$ :

$$t_{\theta} = F_{\chi_n^2}^{-1} (1 - \alpha)$$

$$t_{\theta} = -2\ln\frac{L(\theta)}{L(\hat{\theta})}$$

#### Confidence region from Wilks' theorem (cont.)

i.e., boundary of confidence region in  $\theta$  space is where

$$\ln L(\theta) = \ln L(\hat{\theta}) - \frac{1}{2} F_{\chi_n^2}^{-1} (1 - \alpha)$$

For example, for  $1 - \alpha = 68.3\%$  and n = 1 parameter,

$$F_{\chi_1^2}^{-1}(0.683) = 1$$

and so the 68.3% confidence level interval is determined by

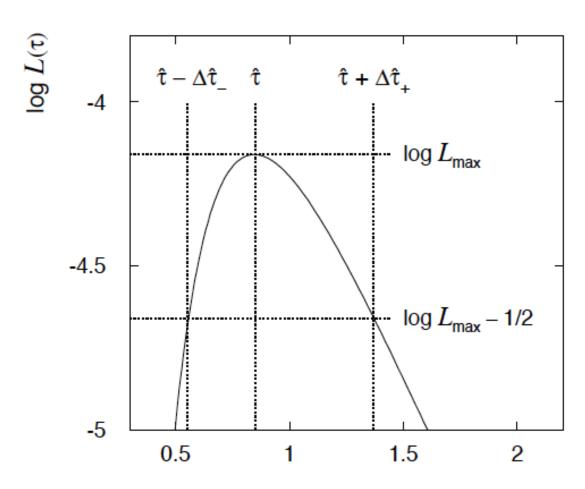
$$\ln L(\theta) = \ln L(\hat{\theta}) - \frac{1}{2}$$

Same as recipe for finding the estimator's standard deviation, i.e.,

$$[\hat{\theta} - \sigma_{\hat{\theta}}, \hat{\theta} + \sigma_{\hat{\theta}}]$$
 is a 68.3% CL confidence interval.

## Example of interval from $\ln L(\theta)$

For n=1 parameter, CL = 0.683,  $Q_{\alpha} = 1$ .



Our exponential example, now with only n = 5 events.

Can report ML estimate with approx. confidence interval from  $\ln L_{\rm max} - 1/2$  as "asymmetric error bar":

$$\hat{\tau} = 0.85^{+0.52}_{-0.30}$$

#### Multiparameter case

For increasing number of parameters,  $CL = 1 - \alpha$  decreases for confidence region determined by a given

$$Q_{\alpha} = F_{\chi_n^2}^{-1}(1 - \alpha)$$

$Q_{lpha}$	$1-\alpha$						
	n = 1	n=2	n = 3	n=4	n = 5		
1.0	0.683	0.393	0.199	0.090	0.037		
2.0	0.843	0.632	0.428	0.264	0.151		
4.0	0.954	0.865	0.739	0.594	0.451		
9.0	0.997	0.989	0.971	0.939	0.891		

#### Multiparameter case (cont.)

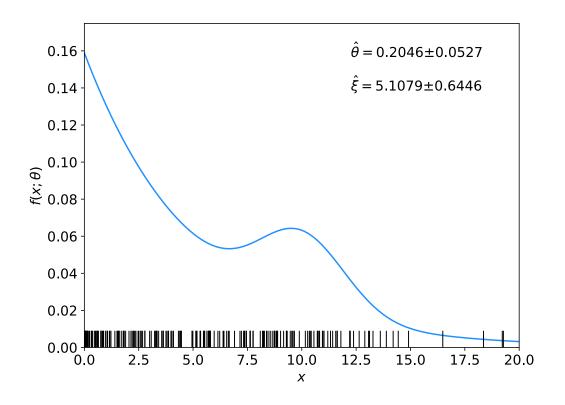
Equivalently,  $Q_{\alpha}$  increases with n for a given  $CL = 1 - \alpha$ .

1 0	$ar{Q}_{lpha}$						
$1-\alpha$	n = 1	n = 2	n = 3	n=4	n = 5		
0.683	1.00	2.30	3.53	4.72	5.89		
0.90	2.71	4.61	6.25	7.78	9.24		
0.95	3.84	5.99	7.82	9.49	11.1		
0.99	6.63	9.21	11.3	13.3	15.1		

#### Example: 2 parameter fit:

Example from problem sheet 8, i.i.d. sample of size 200

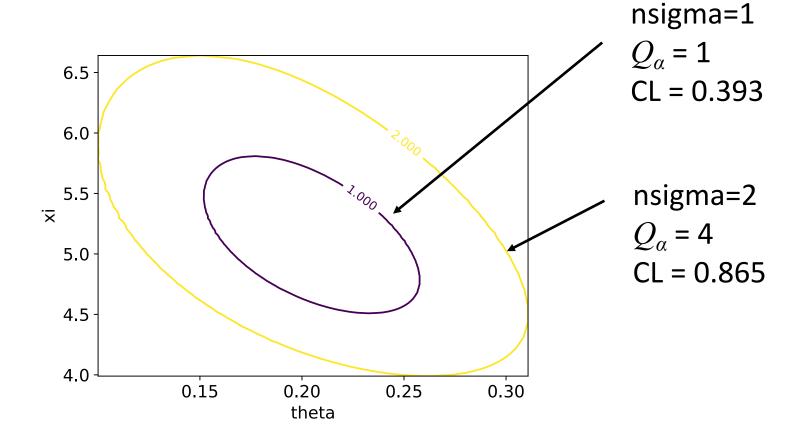
$$x \sim f(x; \theta, \xi) = \theta \frac{1}{\sqrt{2\pi}\sigma} e^{-(x-\mu)^2/2\sigma^2} + (1-\theta)\frac{1}{\xi} e^{-x/\xi}$$



Here fit two parameters:  $\theta$  and  $\xi$ .

#### Example: 2 parameter fit:

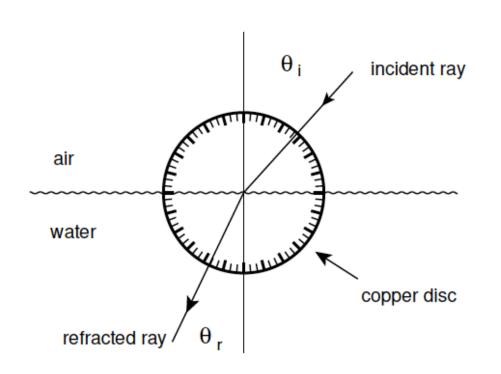
In iminuit, user can set nsigma =  $\sqrt{Q_{\alpha}}$ 



#### Extra slides

## LS example: refraction data from Ptolemy

Astronomer Claudius Ptolemy obtained data on refraction of light by water in around 140 A.D.:



Angles of incidence and refraction (degrees)

$ heta_{ m r}$
8
$15\frac{1}{2}$
$22\frac{1}{2}$
29
35
$40\frac{1}{2}$
$45\frac{1}{2}$
50

Suppose the angle of incidence is set with negligible error, and the measured angle of refraction has a standard deviation of  $\frac{1}{2}$ °

#### Laws of refraction

A commonly used law of refraction was

$$\theta_{\rm r} = \alpha \theta_{\rm i}$$

although it is reported that Ptolemy preferred

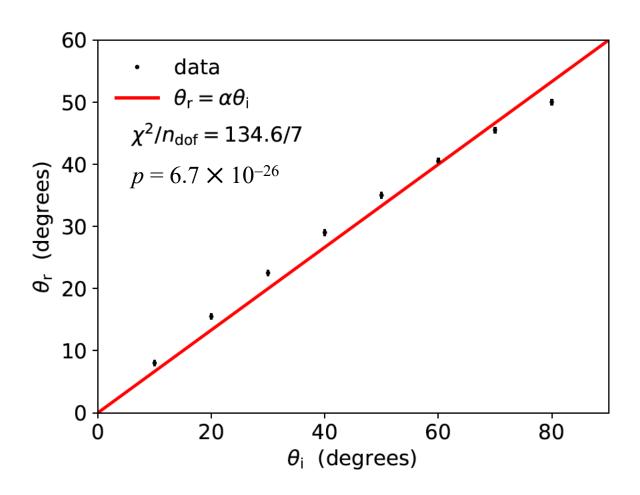
$$\theta_{\rm r} = \alpha \theta_{\rm i} - \beta \theta_{\rm i}^2 .$$

The law of refraction discovered by Ibn Sahl in 984 (and rediscovered by Snell in 1621) is

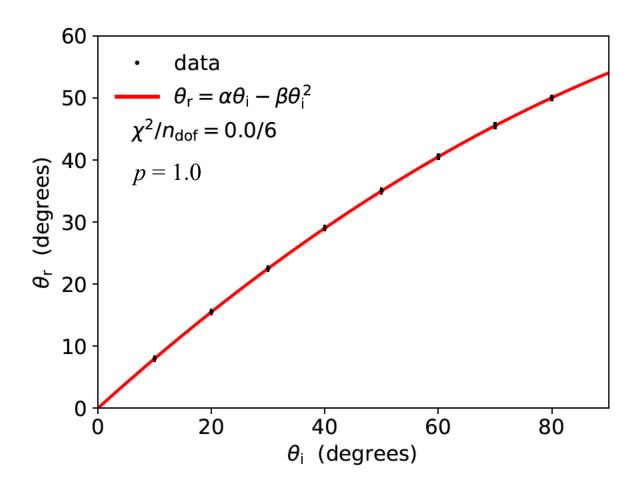
$$\theta_{\rm r} = \sin^{-1} \left( \frac{\sin \theta_{\rm i}}{r} \right)$$

where  $r = n_r/n_i$  is the ratio of indices of refraction of the two media.

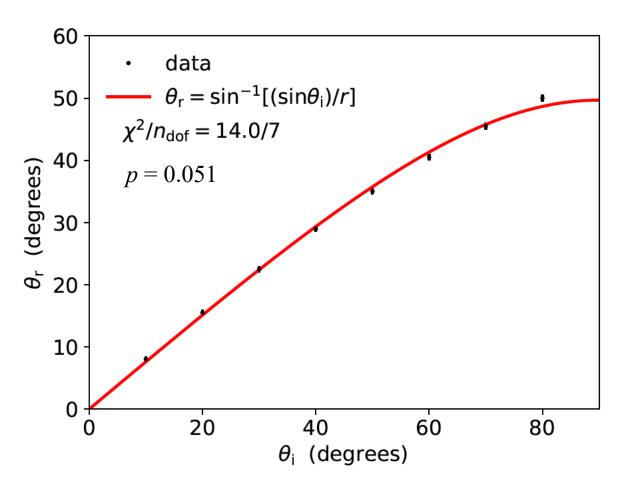
## LS fit: $\theta_{\rm r} = \alpha \theta_{\rm i}$



## LS fit: $\theta_{\rm r} = \alpha \theta_{\rm i} - \beta \theta_{\rm i}^2$



#### LS fit: Snell's Law



Fitted index of refraction of water  $r = 1.3116 \pm 0.0056$  found not quite compatible with currently known value 1.330.